Design and Analysis of Experiments Conference - The Ohio State University. The conference series Design and Analysis of Experiments (DAE) grew out of a series of early conferences that began in 2000. This conference series is to provide support and encouragement to junior researchers in the field of experimental design. The purpose of the Design and Analysis of Experiments DAE conference is to bring together researchers from a variety of disciplines, including statistics, engineering, computer science, and other fields, to share their research and promote collaboration. The conference series is a great opportunity for researchers to present their work, network with colleagues, and learn about the latest developments in the field. The conference series is also a great opportunity for students to present their research and receive feedback from experienced researchers. The conference series is supported by the Society for Industrial and Applied Mathematics (SIAM) and is held in cooperation with a variety of organizations, including the American Statistical Association (ASA) and the Institute for Operations Research and the Management Sciences (INFORMS). The conference series is also supported by a variety of sponsors, including the National Science Foundation (NSF) and the National Institute of Standards and Technology (NIST). The conference series is a great opportunity for researchers to network with colleagues, share their research, and learn about the latest developments in the field. The conference series is also a great opportunity for students to present their research and receive feedback from experienced researchers. The conference series is supported by the Society for Industrial and Applied Mathematics (SIAM) and is held in cooperation with a variety of organizations, including the American Statistical Association (ASA) and the Institute for Operations Research and the Management Sciences (INFORMS). The conference series is also supported by a variety of sponsors, including the National Science Foundation (NSF) and the National Institute of Standards and Technology (NIST).